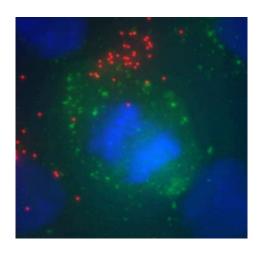
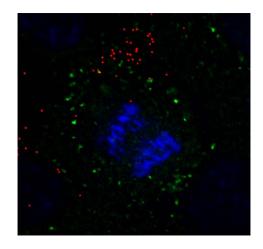
### Imperial College London



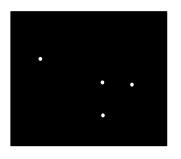
# "Microscopic image restoration by deconvolution"

## **Martin Spitaler**

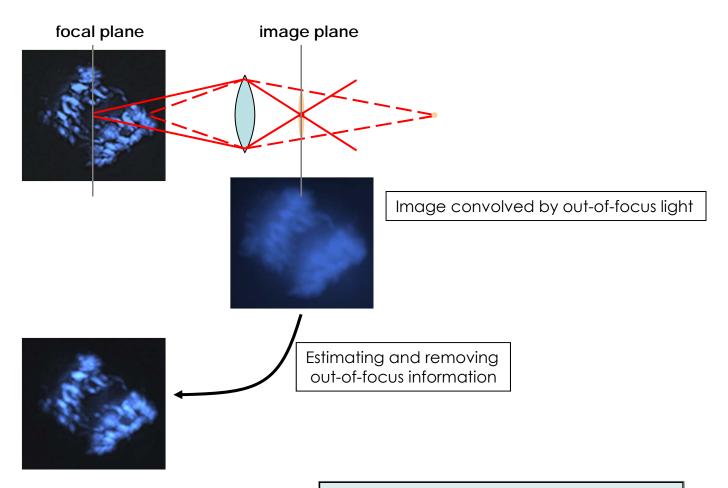








### What is deconvolution?

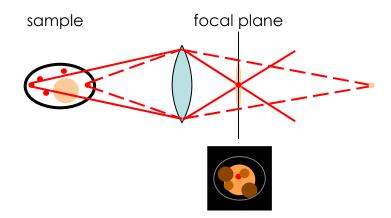


#### Convolution:

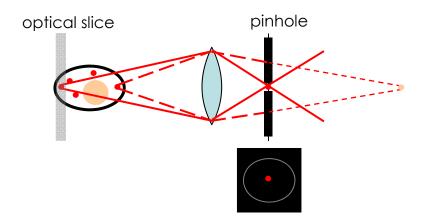
"Mathematical term for combining two signals to form a third signal."

## Why deconvolution?

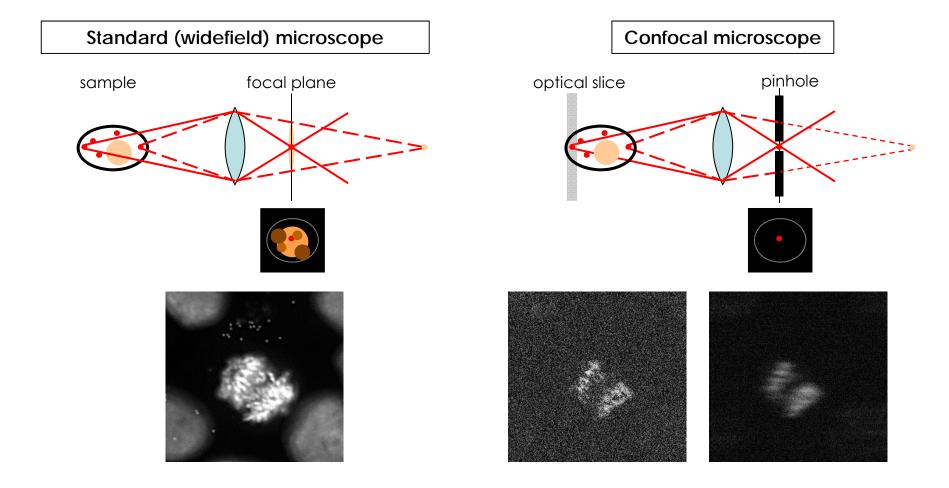
### Standard (widefield) microscope



### Confocal microscope



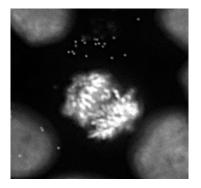
## Why deconvolution?



### Why deconvolution?

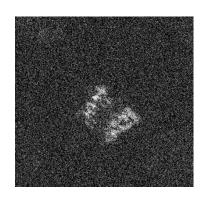
#### Standard (widefield) microscope

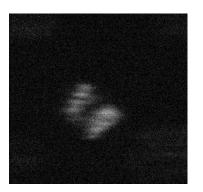
- 3D information convolved by out-of-focus light
- high sensitivity:
  - •Low light exposure
  - •Good signal-to-noise ratio
- •fast
- •(high resolution)

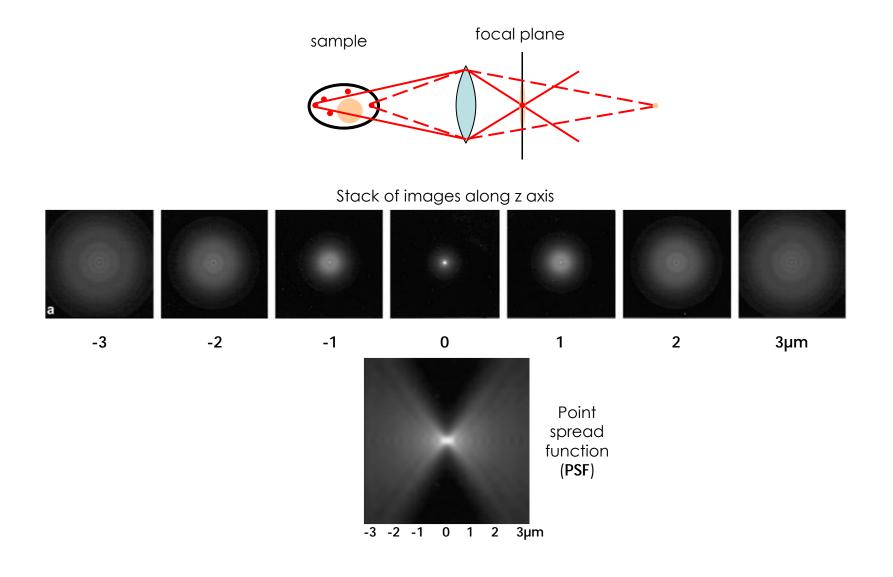


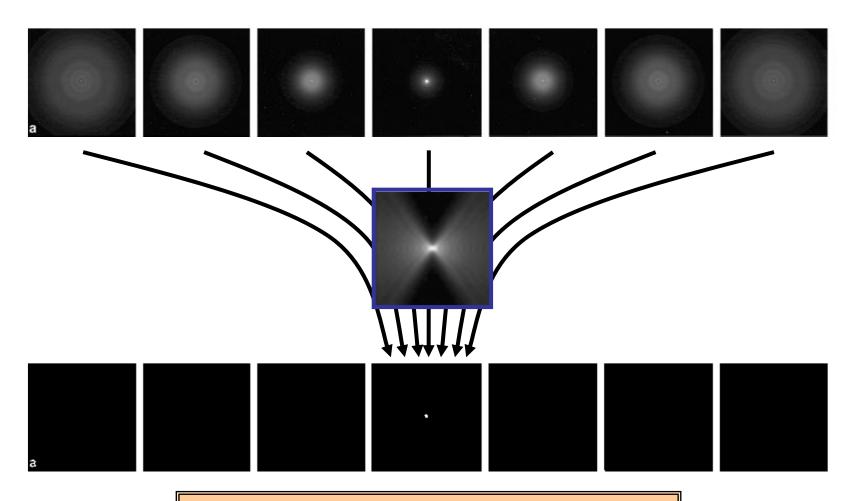
#### Confocal microscope

- intrinsic 3D information
- scanning technique → slow
- modest sensitivity / high phototoxicity:
  - •Strong laser intensities (8x averaging // 40 stacks // 1min per timepoint // 10 min = 3200 light exposures !!)
  - → bleaching, phototoxicity
- (Modest resolution)

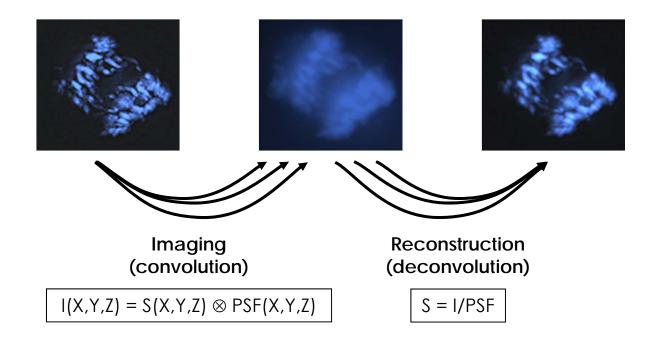




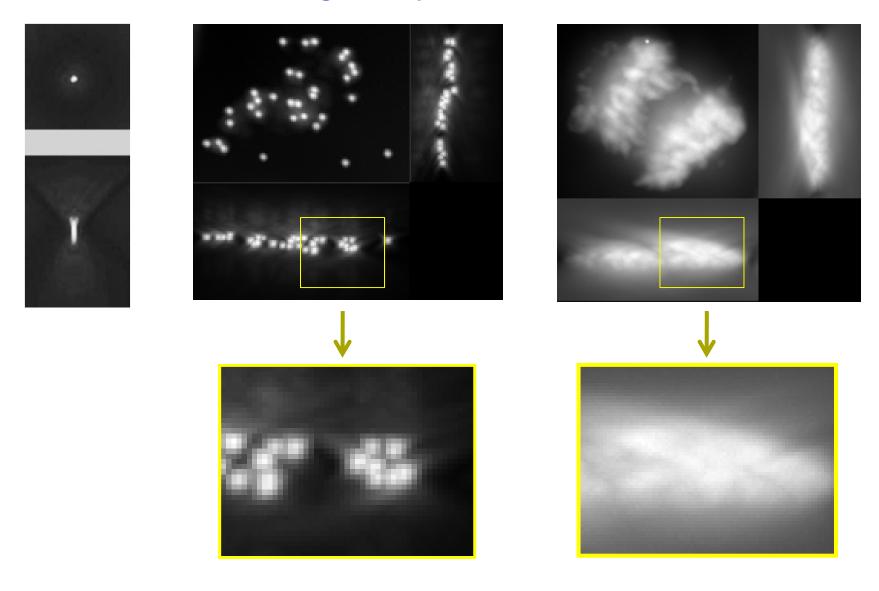




Out-of-focus information is moved back to its estimated origin (no information is lost in the process!)



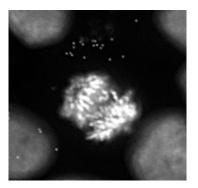
## Challenge: complex 3D structures

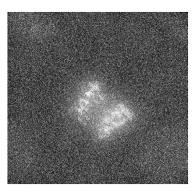


**Challenge: Noise** 

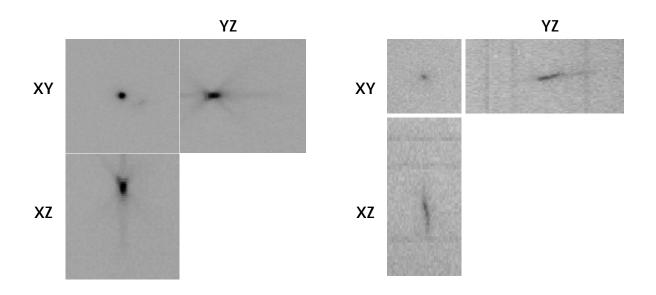
#### Problem:

- Adds additional unknown, random component to the image **Types of noise**:
- Photon noise (statistically irregular photon detection at very low light intensity)
- Detector noise (dark noise, readout noise, amplifier noise), increases with temperature and gain



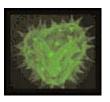


## **Challenge: Optical aberrations**



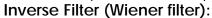
#### Principles of deconvolution: Algorithms

#### One-step linear methods

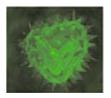


#### No/Nearest Neighbour:

- •deblurring one 2D image slice at a time, comparing it with the one above and below (nearest neighbour)
- •approximation that the out-of-focus contribution in the image slice is equal to a blurred version of the collected adjacent slices
- •fast but imprecise, heavily affected by noise



- •image process dividing the captured image by the PSF
- •fast and effective to remove the majority of the blur
- •noise is managed through adjustable smoothing operation



#### Advantage:

• Fast (real time)

#### Disadvantage:

- Imprecise
- Removes information (not quantitative)
- Heavily affected by noise and imaging aberrations

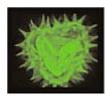
#### Principles of deconvolution: Algorithms

#### <u>Iterative constrained methods (statistical image restoration)</u>



#### Non-Blind:

- •requires a measured PSF
- •PSF is assumed to be accurate



#### **Adaptive Blind:**

- •<u>iteratively</u> reconstructs <u>both the PSF and best image solution</u> possible from the collected 3D dataset
- •statistical techniques of Maximum Likelihood Estimation (MLE) and Constrained Iteration (CI)
- •does not require a measured or PSF
- •good when noise ratios and / or aberrations are challenging

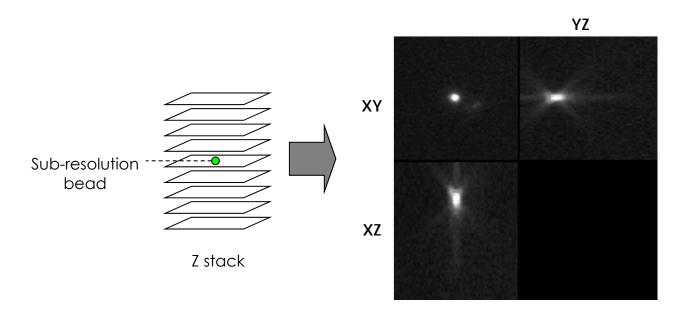
#### Advantage:

- Precise
- All information is preserved (quantitative)
- Adaptive (can correct noise and optical aberrations)

#### Disadvantage:

• Can be extremely computer-intensive

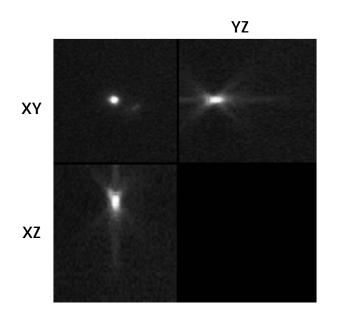
## Measuring the PSF



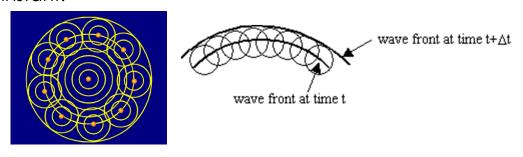
Out-of-focus light is essential for deconvolution!!

→ don't crop PSF <u>and</u> image it in X, Y, Z, intensity (saturation)

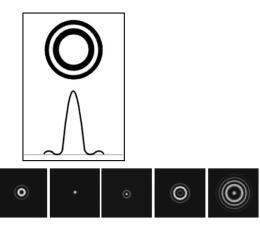
### Measuring the PSF



Huygens' Principle (1678; after <u>Christiaan Huygens</u>): The wavefront of a propagating wave of light at any instant conforms to the envelope of spherical wavelets emanating from every point on the wavefront at the prior instant.



Two-dimensional point spread function of a point source (Airy disk)



#### Measuring the PSF

#### Rules for PSF and sample:

- Clean sample, high-quality coverslips
- <u>Z spacing:</u> ≤Nyquist rate (½ Z resolution)
  e.g. widefield, 63x 1.4NA, GFP (Em 520nm): Z = 277nm
  - → see online Nyquist calculator online
- Choice of objective:

Water: least problems with refractive index mismatch

Oil: least affected by uneven coverslip thickness

- Immersion oil: can be adapted to temperature
- <u>Avoid / correct imaging aberrations</u>
  (uneven illumination / camera sensitivity, sample movement, unstable light)
- Don't crop image and out-of-focus light in X, Y, Z, intensity

### Measuring the PSF

#### Rules for PSF:

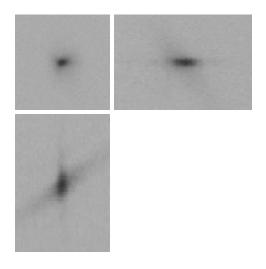
- Bead size: ≤1/3 of XY resolution (1.22λ/2NA), usually 150nm
- <u>Imaging conditions as close as possible to sample:</u>
  - ideally beads added to sample
  - Single beads (PSFs not overlapping)
  - Same NA, fluorescence, objective, NA, mounting medium, temperature, ...
  - Same distance to coverslip
- Optimal image quality (averaging)

→ must be reimaged whenever any part of the imaging system changes!

### (Dis)Advantages of measured PSF

#### Advantage:

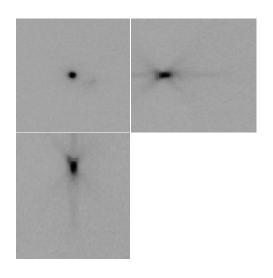
- Accounts best for any aberrations specific for the acquisition setup (individual aberration of lenses, mounting medium, ...)
- Speeds up computation (fewer iterations, 10-100)



blue

#### Disadvantage:

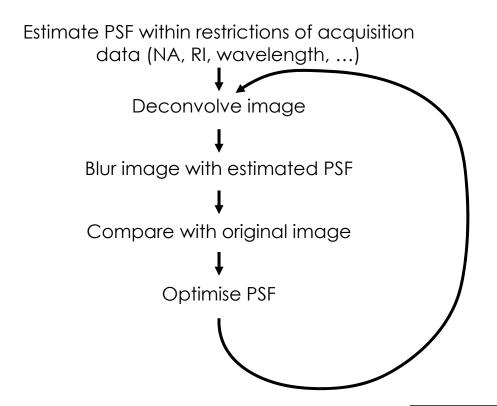
- Acquiring a perfect PSF is virtually impossible:
  - Noise
  - Imaging conditions not identical to sample
  - Changes with distance to coverslip



red

### Blind deconvolution (calculated PSF)

Tries to solve the convolution problem for both the image and the PSF from a single dataset

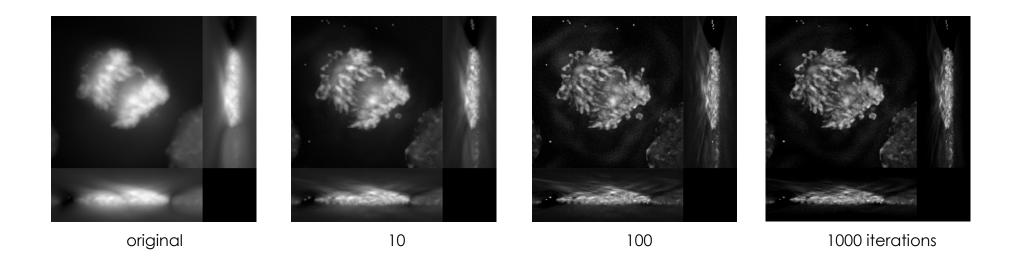


$$\begin{split} \hat{h}^{k}_{i+1}(x,y,z) = & \left\{ \left[ \frac{g(x,y,z)}{\hat{h}^{k}_{i}(x,y,z) \otimes \hat{f}^{k-1}(x,y,z)} \right] \\ & \otimes \hat{f}^{k-1}(-x,-y,-z) \right\} \hat{h}^{k}_{i}(x,y,z), \\ \hat{f}^{k}_{i+1}(x,y,z) = & \left\{ \left[ \frac{g(x,y,z)}{\hat{f}^{k}_{i}(x,y,z) \otimes \hat{h}^{k-1}(x,y,z)} \right] \\ & \otimes \hat{h}^{k-1}(-x,-y,-z) \right\} \hat{f}^{k}_{i}(x,y,z), \end{split}$$

#### **Needed information**

- Imaging mode (widefield, confocal, ...)
- Magnification
- Numerical aperture
- Pixel dimensions (X,Y,Z)
- Refractive index immersion oil
- Refractive index mounting medium
- Thickness coverslip (water objectives)
- Emission wavelength
- Distance from coverslip

## **Examples**



### Blind deconvolution (calculated PSF)

### (Dis)Advantages of calculated PSF

#### Advantage:

- Most flexible and adaptive
- Accounts for variations within an image (in XY, variable distance from coverslip)
- The object estimate converges to the most accurate solution as defined by imaging model
- Good when noise and / or aberrations are challenging

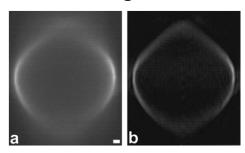
#### Disadvantage:

- One more unknown variable at beginning of deconvolution
- Even more computer intensive (can be >1,000 iterations)
- No PSF quality control during acquisition

### Limits of deconvolution

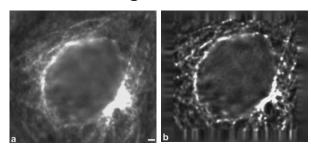
## Potential pitfalls and artefacts

#### **Z** elongation



<u>Prevention:</u> confocal (+ deconvolution)

#### **Edge artefacts**

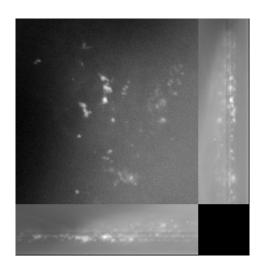


<u>Prevention:</u> object central, sufficient extra space in X, Y, Z, intensity

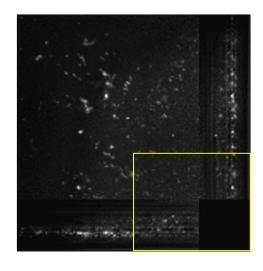
## Limits of deconvolution

## Potential pitfalls and artefacts

**Noise artefacts** 

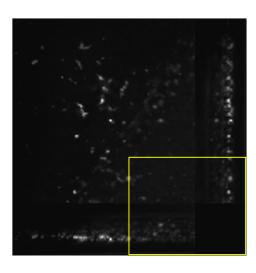


Original

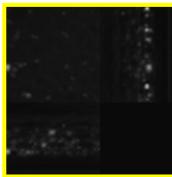


500 iterations blind, **Noise level set to 'low'** 





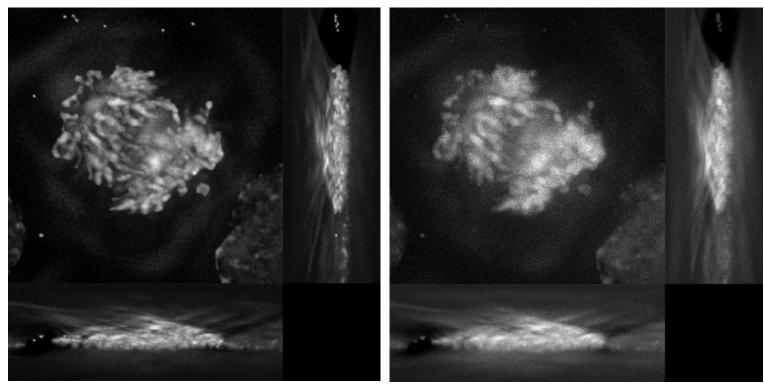
500 iterations blind, **Noise level set to 'high'** 



## Limits of deconvolution

## Potential pitfalls and artefacts

#### Noise artefacts



100 iterations blind, Noise level 'medium'

100 iterations blind, Noise level 'low'

#### Summary: What does deconvolution do

#### Golden rule of deconvolution\*:

"Rubbish in, rubbish out"

- Quantitative method to improve the information content of a 3D image
- Allows to generate accurate 3D data from low-light imaging
- No 'best' method, blind and non-blind iterative methods have their advantage,
  of in doubt best try both
- Deconvolution limited by image quality, noise, aberrations (bottom line:
  Structures must be visible in original data)
- Very efficient for structured images, impossible for diffuse stainings (e.g. "cytosolic")
- Can also be used to improve confocal images, especially if the pinhole has to be opened

\*...and microscopy in general